November 2005

FDP8878 N-Channel PowerTrench<sup>®</sup> MOSFET

FAIRCHILD

SEMICONDUCTOR®

# FDP8878 N-Channel Logic Level PowerTrench<sup>®</sup> MOSFET 30V, 40A, 15mΩ

### **General Descriptions**

This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for low gate charge, low  $r_{DS(ON)}$  and fast switching speed.

### Features

- r<sub>DS(ON)</sub> = 15mΩ, V<sub>GS</sub> = 10V, I<sub>D</sub> = 40A
- r<sub>DS(ON)</sub> = 19mΩ, V<sub>GS</sub> = 4.5V, I<sub>D</sub> = 36A
- High performance trench technology for extremely low rDS(ON)

D

- Low gate charge
- High power and current handling capability
- RoHS Compliant



### FDP SERIES MOSFET Maximum Ratings T<sub>A</sub> = 25°C unless otherwise noted

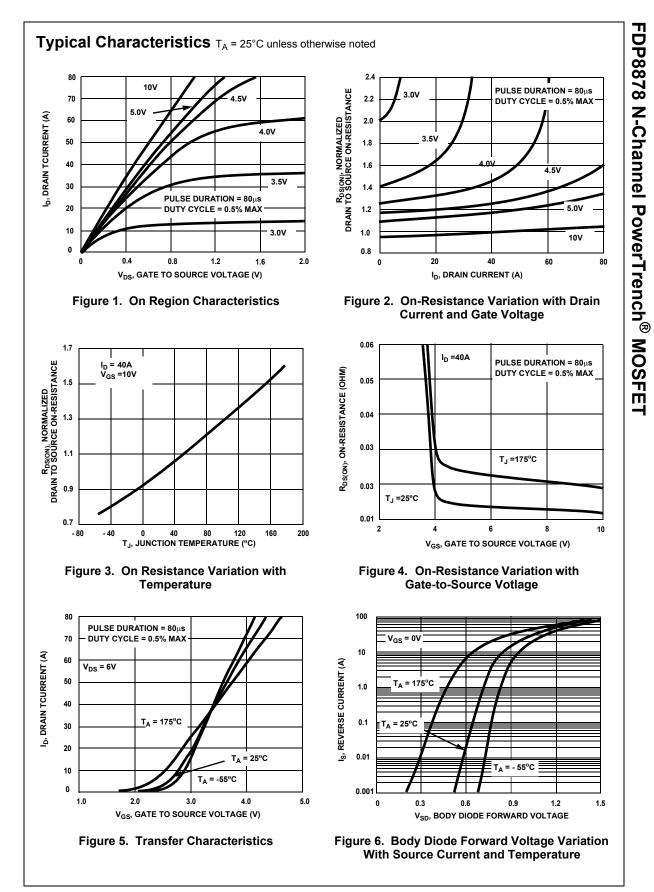
Parameter	Parameter		
Drain to Source Voltage	30	V	
Gate to Source Voltage	±20	V	
Drain Current			
Continuous (T <sub>C</sub> = 25 <sup>o</sup> C, V <sub>GS</sub> = 10V)		40	А
Continuous ( $T_c = 25^{\circ}C$ , $V_{GS} = 4.5V$ )		36	А
Pulsed	(Note 4)	141	Α
Single Pulse Avalanche Energy (Note 1)	L = 1mH, I <sub>AS</sub> = 11A	60	mJ
	L = 43µH,I <sub>AS</sub> = 32A	22	
Power dissipation		40.5	W
Operating and Storage Temperature		-55 to 175	°C
	Drain to Source Voltage Gate to Source Voltage Drain Current Continuous ( $T_C = 25^{\circ}C$ , $V_{GS} = 10V$ ) Continuous ( $T_C = 25^{\circ}C$ , $V_{GS} = 4.5V$ ) Pulsed Single Pulse Avalanche Energy (Note 1) Power dissipation	$\begin{tabular}{ c c c c } \hline Drain to Source Voltage & & & & & & & \\ \hline Gate to Source Voltage & & & & & \\ \hline Drain Current & & & & \\ \hline Continuous (T_C = 25^{\circ}C, V_{GS} = 10V) & & & & \\ \hline Continuous (T_C = 25^{\circ}C, V_{GS} = 4.5V) & & & & \\ \hline Pulsed & & & & (Note 4) & \\ \hline Pulsed & & & & & \\ \hline Single Pulse Avalanche Energy (Note 1) & & & & \\ \hline \begin{array}{c} L = 1mH, I_{AS} = 11A & & \\ \hline L = 43\mu H, I_{AS} = 32A & & \\ \hline \hline Power dissipation & & & & \\ \hline \end{array}$	$\begin{array}{c c c c c c c c c c c c c c c c c c c $

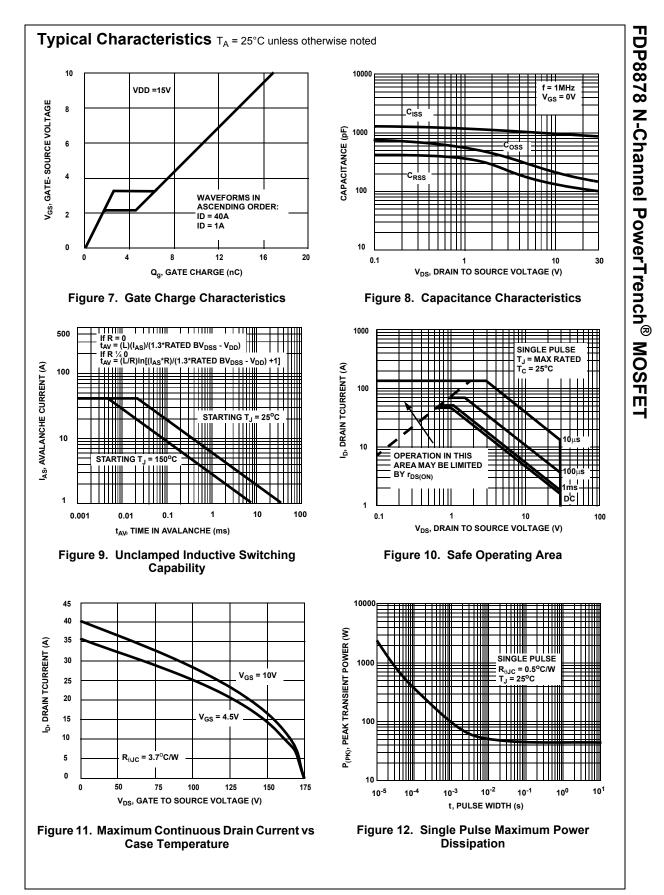
$R_{\theta JC}$	Thermal Resistance, Junction to Case (Note 2)	3.7	°C/W
$R_{\thetaJA}$	Thermal Resistance, Junction to Ambient at 1000 seconds (Note 3)	43	°C/W

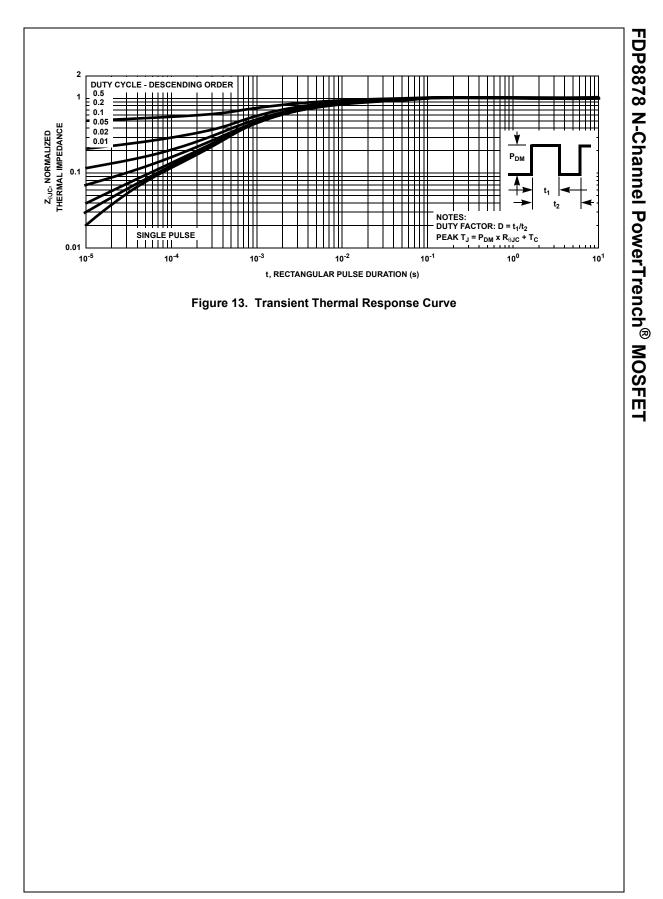
## Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDP8878	FDP8878	TO-220	Tube	n/a	45 units

	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	octeristics					
B <sub>VDSS</sub>	Drain to Source Breakdown Voltage	I <sub>D</sub> = 250μA, V <sub>GS</sub> = 0V	30	-	-	V
∆BV <sub>DSS</sub> ∆TJ	Breakdown Voltage Temp. Coefficient	$I_D = 250 \mu A$ , Referenced to $25^{\circ}C$		21		mV/ºC
	Zoro Coto Voltago Droin Current	V <sub>DS</sub> = 24V	-	-	1	۸
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{GS} = 0V$ $T_A = 150^{\circ}C$	-	-	250	μA
I <sub>GSS</sub>	Gate to Source Leakage Current	$V_{GS}$ = ±20V	-	-	±100	nA
On Chara	cteristics					
V <sub>GS(TH)</sub>	Gate to Source Threshold Voltage	V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> = 250μA	1.2	1.7	2.5	V
$\Delta V_{GS(TH)}$	Gate to Source Threshold Voltage	$I_{\rm D} = 250 \mu A,$				
$\Delta T_J$	Temperature Coefficient	Referenced to 25°C		-5		mV/º(
		I <sub>D</sub> = 40A, V <sub>GS</sub> = 10V	-	12	15	
DS(ON)	Drain to Source On Resistance	I <sub>D</sub> = 36A, V <sub>GS</sub> = 4.5V	-	16	19	mΩ
00(014)		$I_D = 40, V_{GS} = 10V,$ $T_A = 175^{\circ}C$	-	20	25	
Dynamic	Characteristics					
C <sub>ISS</sub>	Input Capacitance		-	927	1235	pF
C <sub>OSS</sub>	Output Capacitance	$V_{DS} = 15V, V_{GS} = 0V,$	-	188	250	pF
C <sub>RSS</sub>	Reverse Transfer Capacitance	f = 1MHz	-	1130	175	pF
R <sub>G</sub>	Gate Resistance	f = 1MHz		3.0		Ω
Q <sub>g(TOT)</sub>	Total Gate Charge at 10V	$V_{GS}$ = 0V to 10V $V_{DD}$ = 15V	-	17.1	23	nC
Q <sub>g(5)</sub>	Total Gate Charge at 5V	$V_{GS} = 0V \text{ to } 5V  I_D = 40A$	-	9.2	12	nC
Q <sub>gs</sub>	Gate to Source Gate Charge	I <sub>g</sub> = 1.0mA	-	2.6	-	nC
Q <sub>gs2</sub>	Gate Charge Threshold to Plateau	-	-	1.7	-	nC
Q <sub>gd</sub>	Gate to Drain "Miller" Charge	-	-	3.7	-	nC
	g Characteristics (V <sub>GS</sub> = 10V)	·				
t <sub>on</sub>	Turn-On Time		-	255	383	ns
t <sub>d(ON)</sub>	Turn-On Delay Time		-	11.1		ns
t <sub>r</sub>	Rise Time	V <sub>DD</sub> = 15V, I <sub>D</sub> = 40A	-	244		ns
t <sub>d(OFF)</sub>	Turn-Off Delay Time	$V_{GS} = 10V, R_{GS} = 16\Omega$	-	14.8		ns
t <sub>f</sub>	Fall Time		-	35.3		ns
t <sub>OFF</sub>	Turn-Off Time	-	-	50	75	ns
	urce Diode Characteristics				L	
	1	I <sub>SD</sub> = 40A	-	1.1	1.25	V
V <sub>SD</sub>	Source to Drain Diode Voltage	I <sub>SD</sub> = 3.2A	-	0.85	1.2	V
	Reverse Recovery Time	$I_{SD}$ = 40A, d $I_{SD}$ /dt=100A/µs	-	14.4	18.8	ns
t <sub>rr</sub>	Reverse Recovered Charge	I <sub>SD</sub> = 40A, dI <sub>SD</sub> /dt=100A/μs		5.1	6.7	nC







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